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<ul> <li>Controlled Baseline</li> <li>– One Assembly/Test Site, One Fabrication</li> </ul>		CKAGE VIEW)
Site		748 1LE
<ul> <li>Extended Temperature Performance of</li> </ul>	1Q1 [] 2	48 1 1LE 47 1D1
–40°C to 125°C	1Q2 [] 3	47 1 1D1 46 1 1D2
Enhanced Diminishing Manufacturing	GND 4	46   102 45   GND
Sources (DMS) Support	1Q3 5	45 0 GND 44 1 1D3
Enhanced Product Change Notification	1Q3 []5 1Q4 []6	44 1 1D3 43 1 1D4
		43 V <sub>CC</sub>
Qualification Pedigree <sup>†</sup>	1Q5 8	41 1D5
Member of the Texas Instruments	1Q6 <b>[</b> ] 9	40 1D6
Widebus™ Family		39 GND
<ul> <li>Inputs Are TTL-Voltage Compatible</li> </ul>	1Q7 [] 11	38 1D7
<ul> <li>3-State Bus Driving True Outputs</li> </ul>	1Q8 [ 12	37 1D8
Full Parallel Access for Loading	2Q1 🛛 13	36 2D1
<ul> <li>Distributed V<sub>CC</sub> and GND Pins Minimize</li> </ul>	2Q2 🚺 14	35 🛛 2D2
High-Speed Switching Noise	GND 🛛 15	34 🛛 GND
<sup>†</sup> Component qualification in accordance with JEDEC and industry	2Q3 🛛 16	33 🛛 2D3
standards to ensure reliable operation over an extended	2Q4 🛛 17	32 2D4
temperature range. This includes, but is not limited to, highly	V <sub>CC</sub> 18	31 VCC
accelerated stress test (HAST) or biased 85/85, temperature cycle, autoclave or unbiased HAST, electromigration, bond	2Q5 🛛 19	30 2D5
intermetallic life, and mold compound life.	2Q6 20	29 2D6
	GND 21	28 GND
description	2Q7 22	27 2D7
The SN74ACT16373Q-EP is a 16-bit D-type	2Q8 23	26 2D8
transparent latch with 3-state outputs designed	2 <mark>0E</mark> 24	25 2LE

#### d

The SN74ACT16373Q-EP is a 16-bit D-type transparent latch with 3-state outputs, designed specifically for driving highly capacitive or relatively low-impedance loads. It is particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

This device can be used as two 8-bit latches or one 16-bit latch. The Q outputs of the latches follow the data (D) inputs if the latch-enable (LE) input is taken high. When LE is taken low, the Q outputs are latched at the levels set up at the D inputs.

A buffered output-enable (OE) input can be used to place the outputs in either a normal logic state (high or low logic levels) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and the increased drive provide the capability to drive bus lines in a bus-organized system, without need for interface or pullup components.

OE does not affect the internal operations of the latches. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.



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#### **ORDERING INFORMATION**

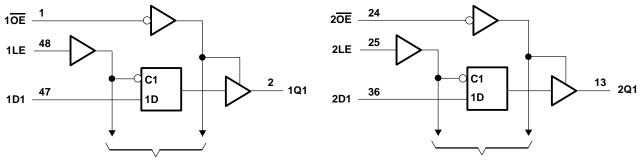
TA	PACKAGE <sup>†</sup>		ORDERABLE PART NUMBER	TOP-SIDE MARKING
-40°C to 125°C	SSOP – DL	Tape and reel	SN74ACT16373QDLREP	ACT16373QEP

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

(each section)								
	INPUTS	OUTPUT						
OE	LE	D	Q					
L	Н	Н	Н					
L	н	L	L					
L	L	Х	Q <sub>0</sub>					
Н	Х	Х	Z					

#### FUNCTION TABLE (each section)

## logic diagram (positive logic)



**To Seven Other Channels** 

To Seven Other Channels

#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>‡</sup>

Supply voltage range, V <sub>CC</sub> Input voltage range, V <sub>I</sub> (see Note 1)	
Output voltage range, V <sub>O</sub> (see Note 1)	–0.5 V to V <sub>CC</sub> + 0.5 V
Input clamp current, $I_{IK}$ ( $V_I < 0$ or $V_I > V_{CC}$ )	±20 mA
Output clamp current, $I_{OK}$ ( $V_O < 0$ or $V_O > V_{CC}$ )	±24 mA
Continuous output current, $I_O (V_O = 0 \text{ to } V_{CC})$	±24 mA
Continuous current through V <sub>CC</sub> or GND	±260 mA
Maximum power dissipation at $T_A = 55^{\circ}C$ (in still air) (see Note 2): DL package	1.2 W
Storage temperature range, T <sub>stg</sub>	–65°C to 150°C

<sup>‡</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils.



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## recommended operating conditions (see Note 3)

		MIN	MAX	UNIT
VCC	Supply voltage (see Note 4)	4.5	5.5	V
VIH	High-level input voltage	2		V
VIL	Low-level input voltage		0.8	V
VI	Input voltage	0	VCC	V
Vo	Output voltage	0	VCC	V
ЮН	High-level output current		-16	mA
IOL	Low-level output current		16	mA
$\Delta t/\Delta v$	Input transition rise or fall rate	0	10	ns/V
TA	Operating free-air temperature	-40	125	°C

NOTES: 3. Unused inputs should be tied to V<sub>CC</sub> through a pullup resistor of approximately 5 kΩ or greater to prevent them from floating. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

4. All V<sub>CC</sub> and GND pins must be connected to the proper-voltage power supply.

#### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	Vee	T <sub>A</sub> = 25°C			MIN MAX	МАХ	UNIT
FARAMETER	TEST CONDITIONS	Vcc	MIN	TYP	MAX		WAA	
	I <sub>OH</sub> = -50 μA	4.5 V	4.4			4.4		
	10H = -20 ftt	5.5 V	5.4			5.4		
VOH	I <sub>OH</sub> = -16 mA	4.5 V	3.94			3.7		V
		5.5 V	4.94			4.7		
	$I_{OH} = -24 \text{ mA}^{\dagger}$	5.5 V				3.85		
	I <sub>OL</sub> = 50 μA	4.5 V			0.1		0.1	
	$OL = 50 \mu A$	5.5 V			0.1		0.1	V
VOL	I <sub>OL</sub> = 16 mA	4.5 V			0.36		0.5	
		5.5 V			0.36		0.5	
	$I_{OL} = 24 \text{ mA}^{\dagger}$	5.5 V					0.5	
lj	$V_I = V_{CC}$ or GND	5.5 V			±0.1		±1	μA
I <sub>OZ</sub>	$V_{O} = V_{CC}$ or GND	5.5 V			±0.5		±10	μA
ICC	$V_{I} = V_{CC} \text{ or } GND, \qquad I_{O} = 0$	5.5 V			8		160	μA
$\Delta I_{CC}$	One input at 3.4 V, Other inputs at GND or $V_{CC}$	5.5 V			0.9		1	mA
Ci	$V_{I} = V_{CC}$ or GND	5 V		4.5				pF
Co	$V_{I} = V_{CC}$ or GND	5 V		12				pF

<sup>†</sup> Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

<sup>‡</sup> This is the increase in supply current for each input that is at one of the specified TTL-voltage levels rather than 0 V to V<sub>CC</sub>.

#### timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

	T		T <sub>A</sub> = 25°C		мах	UNIT
		MIN	MAX	MIN	IVIAA	UNIT
tw	Pulse duration, LE high	4		4		ns
t <sub>su</sub>	Setup time, data before LE $\downarrow$	1		1		ns
th	Hold time, data after LE $\downarrow$	5		5		ns



# SN74ACT16373Q-EP **16-BIT D-TYPE TRANSPARENT LATCH** WITH 3-STATE OUTPUTS SCAS678B - MAY 2002 - REVISED JULY 2002

# switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

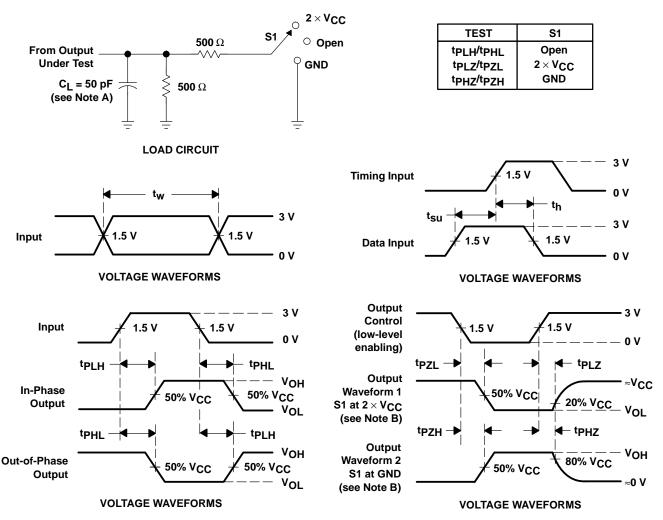
PARAMETER	FROM	то	T <sub>A</sub> = 25°C			MIN	МАХ	UNIT
FARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX		IVIAA	UNIT
<sup>t</sup> PLH	D	Q	3.8	7.9	9.4	3.8	11.8	ns
<sup>t</sup> PHL	U	Ŷ	3.1	8.2	9.7	3.1	13	115
<sup>t</sup> PLH	LE	Q	4.6	9.3	10.8	4.6	13.7	20
<sup>t</sup> PHL	LL	Y	4.5	9.1	10.5	4.5	13	ns
<sup>t</sup> PZH	OE	Q	3.1	8	9.5	3.1	13	ns
<sup>t</sup> PZL	ÛE	Ŷ	3.8	9.4	11.1	3.8	15.1	115
<sup>t</sup> PHZ	OE	Q	5.3	8.6	9.9	5.3	11	ns
<sup>t</sup> PLZ	UE	ý	4.3	7.4	8.7	4.3	9.8	115

# operating characteristics, $V_{CC} = 5 V$ , $T_A = 25^{\circ}C$

	PARAMETER			TEST CON	TYP	UNIT
C <sub>pd</sub> Power dissipation capacitance per latch	Dower dissinction conscitance per letah	Outputs enabled			43	рF
	Power dissipation capacitance per laten	Outputs disabled	C <sub>L</sub> = 50 pF,	f = 1 MHz	4.5	рг



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#### PARAMETER MEASUREMENT INFORMATION

NOTES: A. C<sub>1</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>f</sub> = 3 ns, t<sub>f</sub> = 3 ns.
- D. The outputs are measured one at a time with one input transition per measurement.

#### Figure 1. Load Circuit and Voltage Waveforms





## PACKAGING INFORMATION

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
SN74ACT16373QDLREP	ACTIVE	SSOP	DL	48	1000	None	Call TI	Level-1-235C-UNLIM
V62/03602-01XE	ACTIVE	SSOP	DL	48	1000	None	Call TI	Level-1-235C-UNLIM

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - May not be currently available - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

None: Not yet available Lead (Pb-Free).

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at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. Green (RoHS & no Sb/Br): TI defines "Green" to mean "Pb-Free" and in addition, uses package materials that do not contain halogens, including bromine (Br) or antimony (Sb) above 0.1% of total product weight.

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDECindustry standard classifications, and peak solder temperature.

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